# **Power MOSFET**

# -60 V, -12 A, Single P-Channel, TO-220

#### **Features**

- Low R<sub>DS(on)</sub>
- Rugged Performance
- Fast Switching
- Pb-Free Package is Available\*

# **Applications**

- Industrial
- Automotive
- Power Supplies

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-60	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	-12	Α
Current (Note 1)	State	T <sub>C</sub> = 85°C		-9.0	
Power Dissipation (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	62.5	W
Continuous Drain	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-2.4	Α
Current (Note 1)	State	T <sub>A</sub> = 85°C		-1.8	
Power Dissipation (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.4	W
Pulsed Drain Current	t <sub>p</sub> =	: 10 μs	I <sub>DM</sub>	-42	Α
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	–55 to 175	°C	
Source Current (Body Diode)			Is	-12	Α
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = -30 V, $V_{G}$ = -10 V, $I_{PK}$ = -12 A, L = 3.0 mH, $R_{G}$ = 3.0 $\Omega$ )			EAS	216	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case	$R_{\theta JC}$	2.4	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	62.5	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1

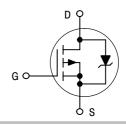


# ON Semiconductor®

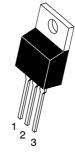
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Typ	I <sub>D</sub> MAX	
-60 V	156 mΩ @ –10 V	-12 A	

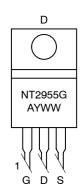
#### P-Channel



### **MARKING DIAGRAM & PIN ASSIGNMENT**



TO-220 CASE 221A STYLE 5



= Assembly Location

= Year ww = Work Week = Pb-Free Package

# **ORDERING INFORMATION**

Device	Package	Shipping
NTP2955	TO-220	50 Units / Rail
NTP2955G	TO-220 (Pb-Free)	50 Units / Rail

<sup>1.</sup> When surface mounted to an FR4 board using 1 in pad size (Cu. area = 1.127 in sq [1 oz] including traces).

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## NTP2955

www.Datellectrical characteristics (T<sub>J</sub>=25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS			•					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				67		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1.0	μΑ	
		$V_{DS} = -48 \text{ V}$	T <sub>J</sub> = 125°C			-10		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{G}$	<sub>S</sub> = ±20 V			±100	nA	
ON CHARACTERISTICS (Note 2)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= -250 μΑ	-2.0		-4.0	V	
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				56		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V,	<sub>D</sub> = -12 A		156	196	mΩ	
Forward Transconductance	9FS	V <sub>DS</sub> = -60 V, I	<sub>D</sub> = -12 A		6.0		S	
CHARGES AND CAPACITANCES	·	1			•			
Input Capacitance	C <sub>ISS</sub>				507	700	pF	
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = V_{DS} = -2$			150	250		
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS - 1			48	98		
Total Gate Charge	Q <sub>G(TOT)</sub>				14		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = -10 V, V <sub>I</sub>	<sub>os</sub> = -48 V,		1.6	2.5		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = -1	2 A		3.4			
Gate-to-Drain Charge	$Q_{GD}$				6.2			
SWITCHING CHARACTERISTICS (No	ote 3)							
Turn-On Delay Time	t <sub>d(on)</sub>				10	20	ns	
Rise Time	t <sub>r</sub>	$V_{GS} = -10 \text{ V}, V_{DD} = -30 \text{ V},$ $I_{D} = -12 \text{ A}, R_{G} = 9.1 \Omega$			41	80		
Turn-Off Delay Time	t <sub>d(off)</sub>				27	47		
Fall Time	t <sub>f</sub>				45	85		
DRAIN-SOURCE DIODE CHARACTE	RISTICS							
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		-1.6	-2.0	V	
		I <sub>S</sub> = -12 A	T <sub>J</sub> = 125°C		-1.36		7	
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -12 \text{ A}$			53			
Charge Time	t <sub>a</sub>				42		ns	
Discharge Time	t <sub>b</sub>				12			
Reverse Recovery Charge	Q <sub>RR</sub>				126		nC	

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

## NTP2955

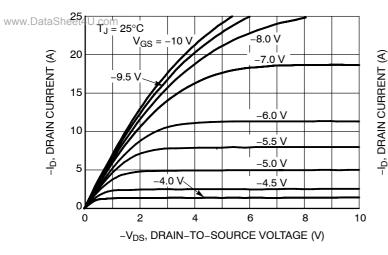


Figure 1. On-Region Characteristics

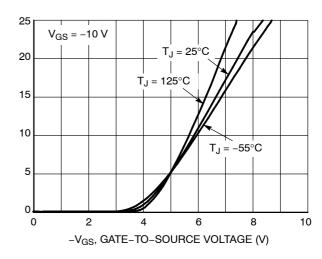


Figure 2. Transfer Characteristics

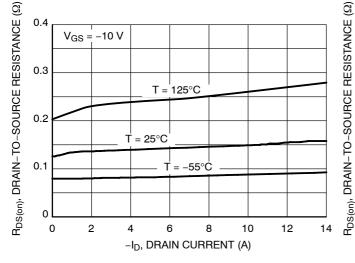


Figure 3. On-Resistance versus Drain Current and Temperature

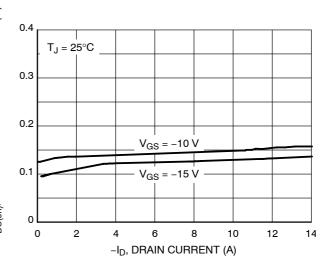


Figure 4. On-Resistance versus Drain Current and Gate Voltage

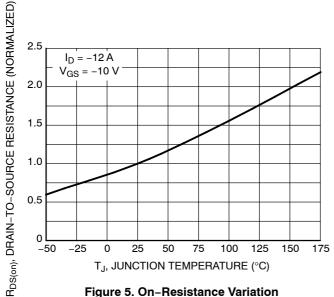


Figure 5. On-Resistance Variation with Temperature

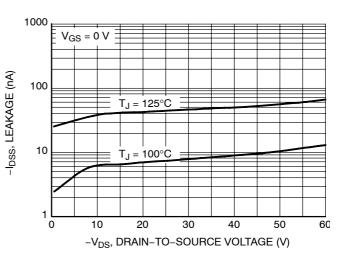
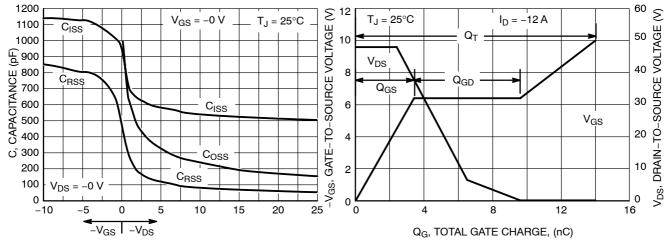


Figure 6. Drain-to-Source Leakage versus Voltage

www.DataSheet4U.com



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

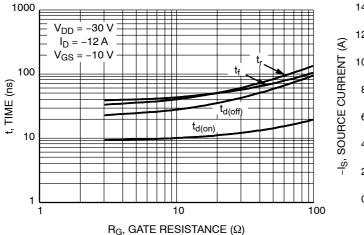


Figure 9. Resistive Switching Time Variation versus Gate Resistance

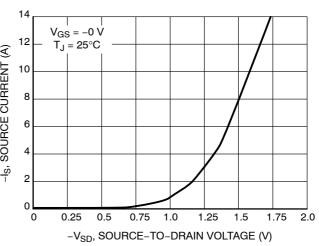


Figure 10. Diode Forward Voltage versus Current

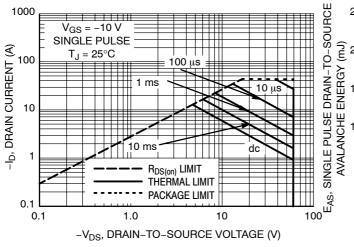


Figure 11. Maximum Rated Forward Biased Safe Operating Area

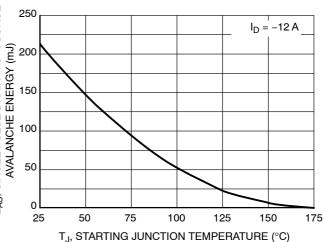
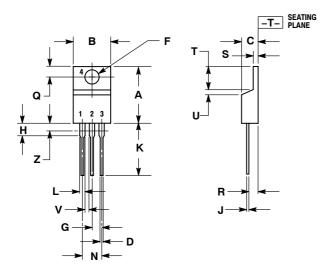


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

#### PACKAGE DIMENSIONS

#### TO-220 T SUFFIX PLASTIC PACKAGE CASE 221A-09 **ISSUE AA**



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14 5M 1982
- THE JOHN 1902-CONTROLLING DIMENSION: INCH. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5: PIN 1. GATE

DRAIN 2.

SOURCE

DRAIN

ON Semiconductor and 📖 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice on semiconductor and ware registered readerlanks of semiconductor Components industries, ICC (SCILLC) solice (Science). Scill Center of the application or use of any product series in engagement of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082-1312 USA Phone: 480-829-7710 or 800-344-3860 Toll Free USA/Canada Fax: 480-829-7709 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

Japan: ON Semiconductor, Japan Customer Focus Center 2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051 Phone: 81-3-5773-3850

ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.